SiC JFET Division

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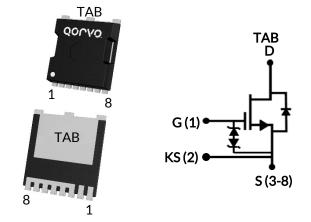


Silicon Carbide (SiC) Cascode JFET -EliteSiC, Power N-Channel, TOLL, 750V, 5.4 mohm

Rev. B, January 2025

DATASHEET

UJ4SC075005L8S



Part Number	Package	Marking
UJ4SC075005L8S	MO-229	UJ4SC075005



Description

The UJ4SC075005L8S is a 750V, $5.4m\Omega$ G4 SiC FET. It is based on a unique 'cascode' circuit configuration, in which a normally-on SiC JFET is co-packaged with a Si MOSFET to produce a normally-off SiC FET device. The device's standard gate-drive characteristics allows use of off-the-shelf gate drivers hence requiring minimal re-design when replacing Si IGBTs, Si superjunction devices or SiC MOSFETs. Available in the space-saving MO-229 package which enables automated assembly, this device exhibits ultra-low gate charge and exceptional reverse recovery characteristics, making it ideal for switching inductive loads and any application requiring standard gate drive.

Features

- On-resistance R_{DS(on)}: 5.4mΩ (typ)
- Operating temperature: 175°C (max)
- Excellent reverse recovery: Q_{rr} = 440nC
- Low body diode V_{ESD}: 1.03V
- Low gate charge: $Q_G = 164nC$
- Threshold voltage V_{G(th)}: 4.7V (typ) allowing 0 to 15V drive
- Low intrinsic capacitance
- ESD protected, HBM class 2
- MO-229 package for faster switching, clean gate waveforms

Typical applications

- Solid state relays and circuit-breakers
- Line rectification and active-bridge rectification circuits in AC/DC front-ends
- EV charging
- PV inverters
- Switch mode power supplies
- Power factor correction modules
- Motor drives
- Induction heating





Maximum Ratings

Parameter	Symbol	Test Conditions	Value	Units
Drain-source voltage	V _{DS}		750	V
Cata source veltage	V _{GS}	DC	-20 to +20	V
Gate-source voltage	V _{GS}	AC (f > 1Hz)	-25 to +25	V
Continuous drain current ¹	I _D	T _C < 144°C	120	А
Pulsed drain current ²	I _{DM}	T _C = 25°C	588	А
Single pulsed avalanche energy ³	E _{AS}	L=15mH, I _{AS} = 6.5A	316	mJ
Short circuit withstand time ⁴	t _{sc}	V _{DS} = 400V, T _{J(START)} = 175°C	5	μs
SiC FET dv/dt ruggedness	dv/dt	$V_{DS} \le 500V$	100	V/ns
Power dissipation	P _{tot}	T _C = 25°C	1153	W
Maximum junction temperature	T _{J,max}		175	°C
Operating and storage temperature	T _J , T _{STG}		-55 to 175	°C
Reflow soldering temperature	T_{solder}	reflow MSL 1	260	°C

1. Limited by bondwires

2. Pulse width t_{p} limited by $T_{J,\text{max}}$

3. Starting $T_J = 25^{\circ}C$

4. Short circuit current is independent of the gate voltage $V_{GS}{>}12V$

Thermal Characteristics

Parameter	Symbol	Symbol Test Conditions		Value			
Parameter	Symbol Test Conditions	Test Conditions	Min	Тур	Max	- Units	
Thermal resistance, junction-to-case	$R_{ ext{ heta}JC}$			0.10	0.13	°C/W	

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Electrical Characteristics (T_J = +25°C unless otherwise specified)

Typical Performance - Static

Parameter	Sumbol	Test Conditions		Linite			
Parameter	Symbol	Test Conditions	Min	Тур	Max	– Units	
Drain-source breakdown voltage	BV _{DS}	V_{GS} =0V, I_{D} =1mA	750			V	
		V _{DS} =750V, V _{GS} =0V, T _J =25°C		6	130		
Total drain leakage current	I _{DSS}	V _{DS} =750V, V _{GS} =0V, T _J =175°C		45		μA	
Total gate leakage current	I _{GSS}	V _{DS} =0V, T _J =25°C, V _{GS} =-20V / +20V		6	20	μΑ	
Drain-source on-resistance		V _{GS} =12V, I _D =80A, T _J =25°C		5.4	7.2		
	R _{DS(on)}	V _{GS} =12V, I _D =80A, T _J =125°C		9.3		mΩ	
		V _{GS} =12V, I _D =80A, T _J =175°C		12.2			
Gate threshold voltage	V _{G(th)}	V_{DS} =5V, I_{D} =10mA	4	4.7	6	V	
Gate resistance	R _G	f=1MHz, open drain		0.8	1.5	Ω	

Typical Performance - Reverse Diode

Parameter	Symbol	Test Conditions		Units			
Parameter	Symbol	Test Conditions	Min	Тур	Max	Units	
Diode continuous forward current ¹	ا _s	T _C < 144°C			120	А	
Diode pulse current ²	I _{S,pulse}	T _C =25°C			588	А	
	M	V _{GS} =0V, I _S =50A, T _J =25°C		1.03	1.16	Ň	
Forward voltage	V_{FSD}	V _{GS} =0V, I _S =50A, T _J =175°C		1.06		V	
Reverse recovery charge	Q _{rr}	V _{DS} =400V, I _S =80A, V _{GS} =0V, R _G =20Ω		440		nC	
Reverse recovery time	t _{rr}	di/dt=2800A/µs, T_=25°C		31		ns	
Reverse recovery charge	Q _{rr}	V_{DS} =400V, I _S =80A, V_{GS} =0V, R _G =20 Ω		525		nC	
Reverse recovery time	t _{rr}	t _{rr} di/dt=2800A/μs, T _J =150°C		37		ns	





Typical Performance - Dynamic

Deverseter	Symbol	Test Conditions		Value		Units	
Parameter	Symbol	Test Conditions	Min	Тур	Max	Units	
Input capacitance	C _{iss}			8374			
Output capacitance	C _{oss}	- V _{DS} =400V, V _{GS} =0V - f=100kHz -		362		pF	
Reverse transfer capacitance	C _{rss}			4			
Effective output capacitance, energy related	C _{oss(er)}	$V_{DS}=0V$ to 400V, $V_{GS}=0V$		475		pF	
Effective output capacitance, time related	C _{oss(tr)}	$V_{DS}=0V$ to 400V, $V_{GS}=0V$		950		pF	
C _{OSS} stored energy	E _{oss}	V _{DS} =400V, V _{GS} =0V		38		μJ	
Total gate charge	Q _G	– V _{DS} =400V, I _D =80A, –		164			
Gate-drain charge	Q_{GD}	$V_{\rm DS} = 400 \text{ V}, \text{ I}_{\rm D} = 50 \text{ A},$ - $V_{\rm GS} = 0 \text{ V to } 15 \text{ V}$		24		nC	
Gate-source charge	Q_{GS}	V _{GS} - 0V to 15V		46			
Turn-on delay time	t _{d(on)}			35		-	
Rise time	t _r	Notes 5 and 6, V _{DS} =400V, I _D =80A, Gate		39			
Turn-off delay time	t _{d(off)}	$\frac{V_{DS}=400V, I_{D}=80A, Gale}{Driver=0V to +15V,}$		109		ns	
Fall time	t _f	Turn-on $R_{G,EXT}$ =1.5 Ω ,		13			
Turn-on energy including R _S energy	E _{ON}	Turn-off R _{G,EXT} =5Ω, inductive Load, FWD:		766		μ	
Turn-off energy including R _s energy	E _{OFF}			162			
Total switching energy	E _{TOTAL}	same device with $V_{GS} = 0V$ and $R_G = 5\Omega$, RC snubber:		928			
Snubber R_s energy during turn-on	E _{RS_ON}	$R_s=5\Omega$ and $C_s=680pF$,		17.6			
Snubber R _s energy during turn-off	E_{RS_OFF}	TJ=22℃		7.2			
Turn-on delay time	t _{d(on)}			37			
Rise time	t _r	Notes 5 and 6, V _{DS} =400V, I _D =80A, Gate		41			
Turn-off delay time	t _{d(off)}	Driver = $0V$ to +15V,		114		– ns	
Fall time	t _f	Turn-on $R_{G,EXT}$ =1.5 Ω , Turn-off $R_{G,EXT}$ =5 Ω , inductive Load, FWD: same device with V_{GS} = 0V and		13		-	
Turn-on energy including R _s energy	E _{ON}			808			
Turn-off energy including R_s energy	E _{OFF}			187		1	
Total switching energy	E_{OFF} device with $V_{GS} = 0V$ and $R_{G} = 5\Omega$, RC snubber: $R_{S} = 5\Omega$ and $C_{S} = 680 \text{pF}$,			995		μJ	
Snubber R_s energy during turn-on	E _{RS_ON}	$ R_s = 5\Omega$ and $C_s = 680 \text{ pr}$, $ T_j = 150^{\circ}\text{C}$		18.3]	
Snubber R _s energy during turn-off	E _{RS_OFF}			10.3]	

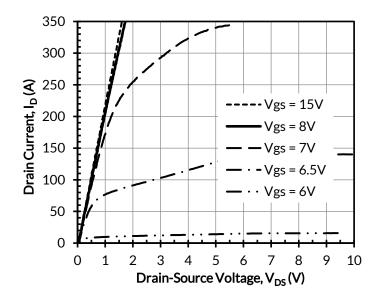
5. Measured with the switching test circuit in Figure 26.

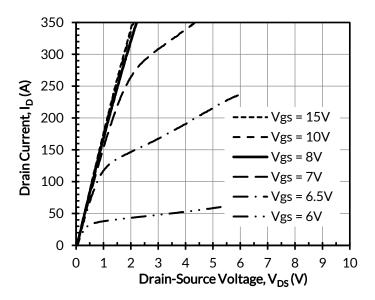
6. In this datasheet, all the switching energies (turn-on energy, turn-off energy and total energy) presented in the tables and Figures include the device RC snubber energy losses.

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Typical Performance Diagrams





< 250µs

Figure 1. Typical output characteristics at $T_1 = -55^{\circ}$ C, tp Figure 2. Typical output characteristics at $T_1 = 25^{\circ}$ C, tp < 250µs

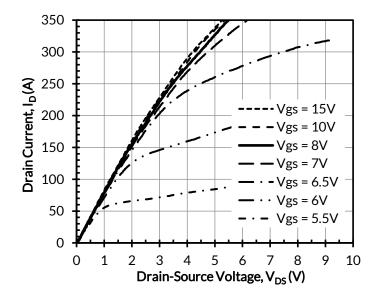


Figure 3. Typical output characteristics at T_J = 175°C, tp < 250µs

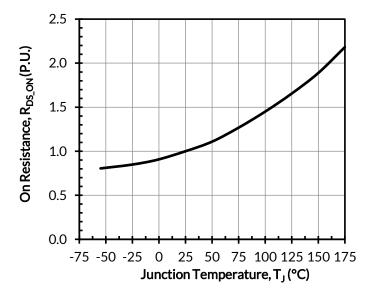


Figure 4. Normalized on-resistance vs. temperature at V_{GS} = 12V and I_D = 80A

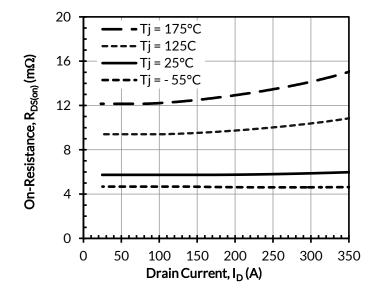


Figure 5. Typical drain-source on-resistances at V $_{\rm GS}$ = 12V

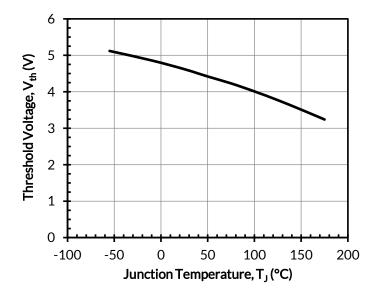
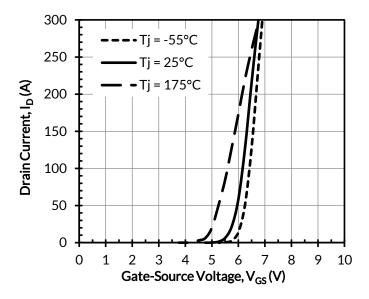


Figure 7. Threshold voltage vs. junction temperature at V_{DS} = 5V and I_{D} = 10mA



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Figure 6. Typical transfer characteristics at V_{DS} = 5V

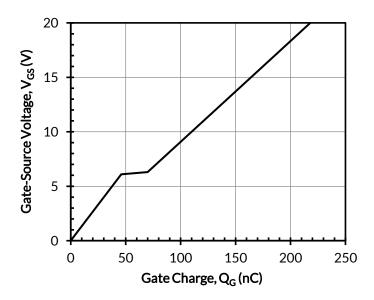


Figure 8. Typical gate charge at V_{DS} = 400V and I_{D} = 80A

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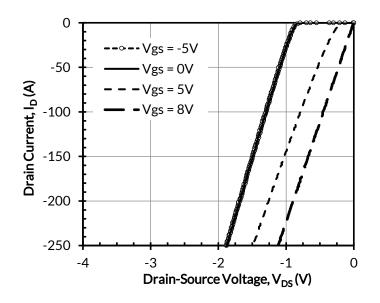


Figure 9. 3rd quadrant characteristics at $T_J = -55^{\circ}C$

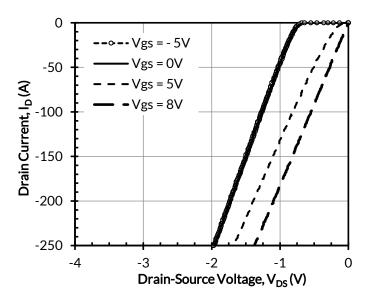


Figure 10. 3rd quadrant characteristics at $T_J = 25^{\circ}C$

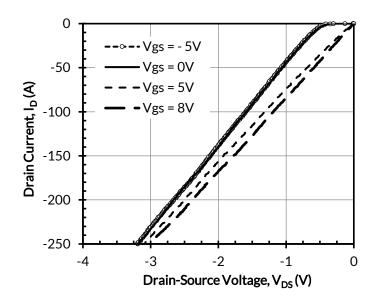


Figure 11. 3rd quadrant characteristics at T_J = 175°C

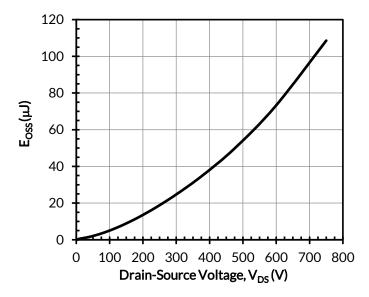


Figure 12. Typical stored energy in C_{OSS} at V_{GS} = 0V

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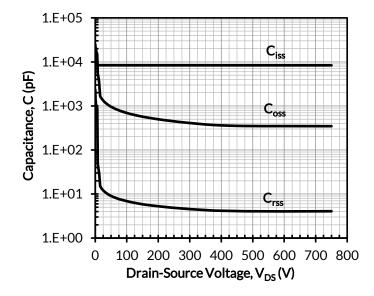
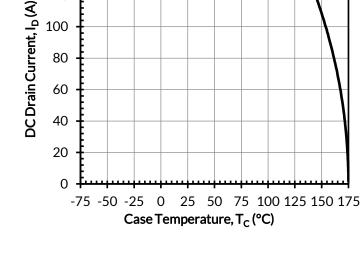


Figure 13. Typical capacitances at f = 100kHz and $V_{GS} = Figure 14$. DC drain current derating 0V



140

120

100

80

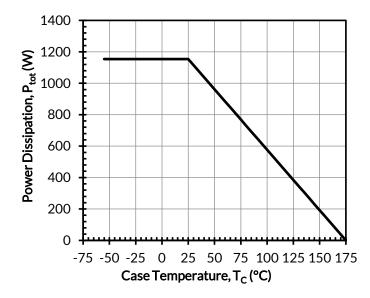


Figure 15. Total power dissipation

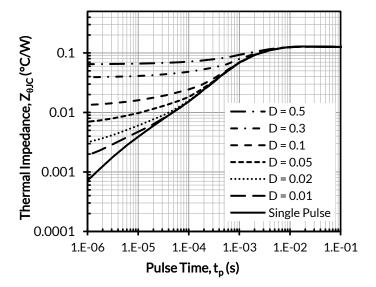


Figure 16. Maximum transient thermal impedance

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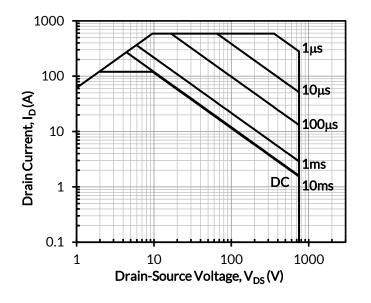
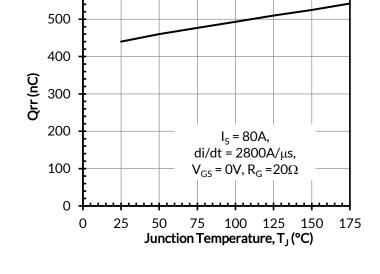


Figure 17. Safe operation area at $T_c = 25^{\circ}C$, D = 0, Parameter t_n



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Figure 18. Reverse recovery charge Qrr vs. junction temperature at V_{DS} = 400V

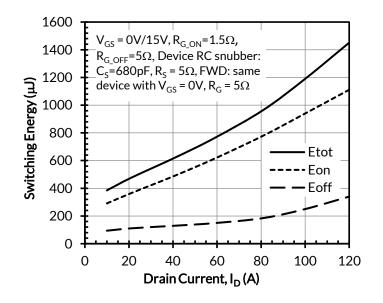
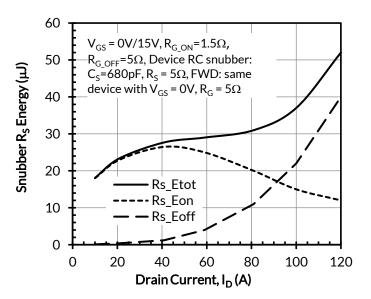


Figure 19. Clamped inductive switching energy vs. drain Figure 20. RC snubber energy loss vs. drain current at current at V_{DS} = 400V and T_J = 25°C



 V_{DS} = 400V and T_{J} = 25°C

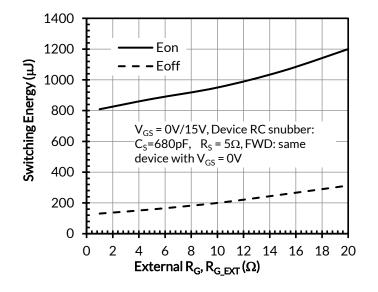
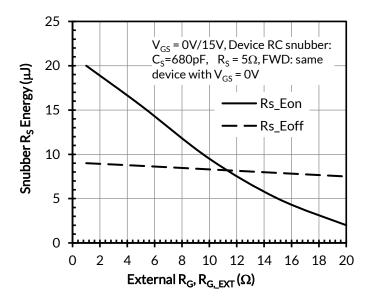


Figure 21. Clamped inductive switching energies vs. $R_{G,EXT}$ at V_{DS} = 400V, I_{D} = 80A, and T_{J} = 25°C



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Figure 22. RC snubber energy losses vs. $R_{G,EXT}$ at V_{DS} = 400V, I_D = 80A, and T_J = 25°C

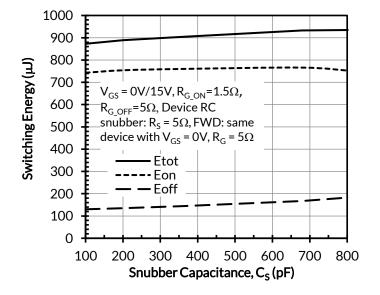


Figure 23. Clamped inductive switching energies vs. snubber capacitance C_s at V_{DS} = 400V, I_D = 80A, and T_J = capacitance C_s at V_{DS} = 400V, I_D = 80A, and T_J = 25°C 25°C

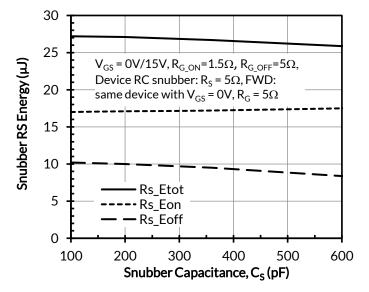


Figure 24. RC snubber energy losses vs. snubber

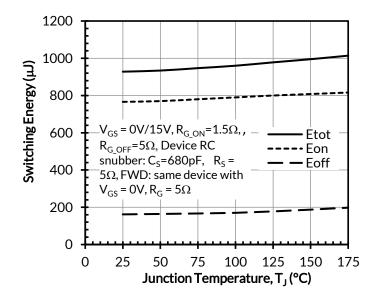
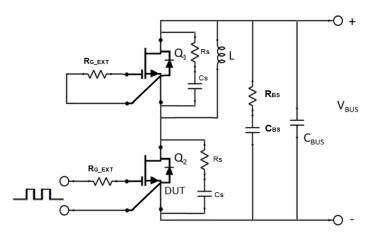


Figure 25. Clamped inductive switching energy vs. junction temperature at V_{DS} =400V and I_D = 80A



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Figure 26. Schematic of the half-bridge mode switching test circuit. Note, a device snubber (Rs =5 Ω , Cs = 680pF) and bus RC snubber (R_{BS} = 1 Ω , C_{BS}=100nF) is used to reduce the power loop high frequency oscillations.

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Applications Information

SiC FETs are enhancement-mode power switches formed by a high-voltage SiC depletion-mode JFET and a low-voltage silicon MOSFET connected in series. The silicon MOSFET serves as the control unit while the SiC JFET provides high voltage blocking in the off state. This combination of devices in a single package provides compatibility with standard gate drivers and offers superior performance in terms of low on-resistance ($R_{DS(on)}$), output capacitance (C_{oss}), gate charge (Q_G), and reverse recovery charge (Q_{rr}) leading to low conduction and switching losses. The SiC FETs also provide excellent reverse conduction capability eliminating the need for an external anti-parallel diode.

Like other high performance power switches, proper PCB layout design to minimize circuit parasitics is strongly recommended due to the high dv/dt and di/dt rates. An external gate resistor is recommended when the FET is working in the diode mode in order to achieve the optimum reverse recovery performance. For more information on SiC FET operation, see www.unitedsic.com.

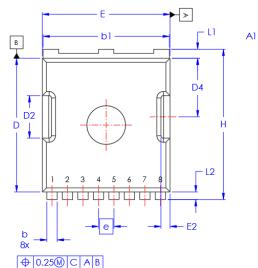
A snubber circuit with a small $R_{(G)}$, or gate resistor, provides better EMI suppression with higher efficiency compared to using a high $R_{(G)}$ value. There is no extra gate delay time when using the snubber circuitry, and a small $R_{(G)}$ will better control both the turn-off $V_{(DS)}$ peak spike and ringing duration, while a high $R_{(G)}$ will damp the peak spike but result in a longer delay time. In addition, the total switching loss when using a snubber circuit is less than using high $R_{(G)}$, while greatly reducing $E_{(OFF)}$ from mid-to-full load range with only a small increase in $E_{(ON)}$. Efficiency will therefore improve with higher load current. For more information on how a snubber circuit will improve overall system performance, visit the UnitedSiC website at www.unitedsic.com

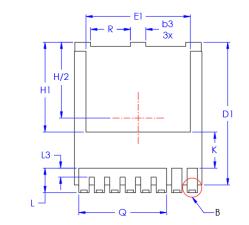
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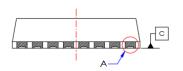
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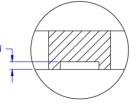


PACKAGE OUTLINE

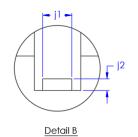








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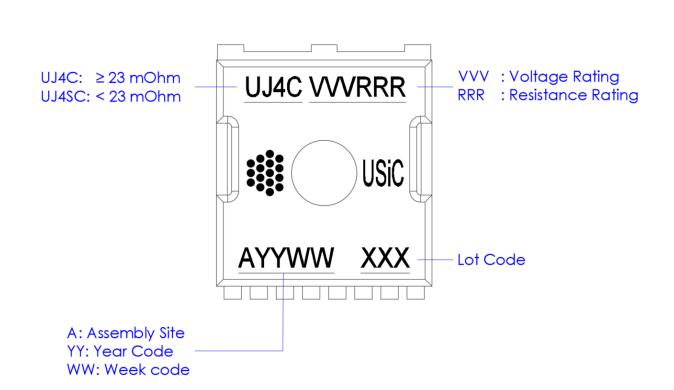
<u>Detail A</u>

- Note: 1. All dimensions in millimeters
 - 2. Dimensions does not include Burrs and Mold Flashes

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SYMBOL	Value						
	Min	Max					
A	2.15	2.45					
Al	1.80	REF					
b	0.65	0.90					
bl	9.65	9.95					
b3	1.10	1.30					
С	0.40	0.60					
D	10.18	10.58					
DI	10.88	11.28					
D2	3.15	3.45					
D4	4.40	4.70					
E	9.70	10.10					
E1	7.95	8.25					
E2	0.60	0.80					
е	1.20 BSC						
Н	11.48	11.88					
H1	6.80	7.10					
i	0.10	REF					
j1	0.46	REF					
j2	0.20	REF					
K	2.80	REF					
L	1.40	2.10					
L1	0.50	0.90					
L2	0.48	0.72					
L3	0.30	0.80					
Q	6.80	REF					
R	3.00	3.20					



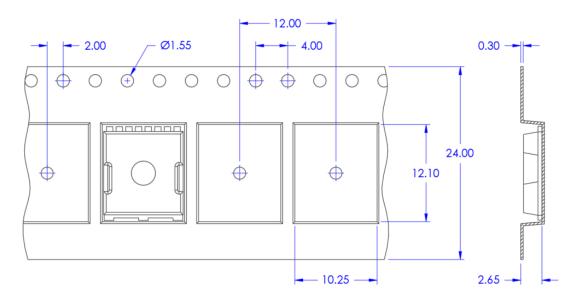
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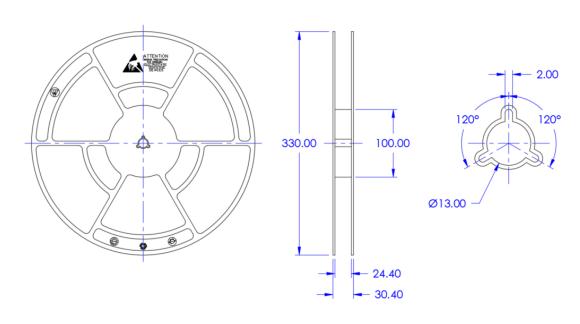


PACKING TYPE

Carrier Tape



<u>Reel</u>



All dimensions in millimeters Quantity per Reel: 2000 units



TOLL PACKAGE OUTLINE, PART MARKING, TAPE AND REEL SPECIFICATION	Page 4 of 4
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REVISION HISTORY

Revision	Create Date (mm/dd/yyyy)	Description of Change	Initiator of Change
A	10/13/2023	Initial Production Release	Glenn Galang
В	01/31/2024	Corrected device orientation inside carrier tape pocket (Page 3)	Glenn Galang

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